Issue	Classifi	ication

Application/Control No.	Applicant(s)/Patent under Reexamination	
09/975,385	CHIU ET AL.	
Examiner	Art Unit	
Carlos Lonez	1731	

ORIG	INAL		CROSS REFERENCE(S)										
CLASS	SUBCLASS	CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)										
264	496	264	259										
INTERNATIONAL	CLASSIFICATION												
B 0 5 D	3/02												
	7												
	2/ arlos Lopez t Examiner) (Date	8/05 e)		STEVEN P. ERVISORY PAT ECHNOLOGY (ENT EXAMIN	Total Claims Allowed: 24							
H) la la	Marshar/ nents Examiner)	///55 (D y le)	ιι (β	imary Examiner	7/1/ 0	O Print C	O.G. Print Fig.						

Claims renumbered in the same order as presented by applicant								□ СРА			☐ T.D.			☐ R.1.47					
Final	Original	2	Final	Original		Final	Original		Final	Original		Final	Original		Final	Original		Final	Original
1	1			31			61			91			121			151			181
2	2			32			62			92			122			152			182
	3			33			63			93			123			153			183
3	4			34			64			94			124			154			184
4	5			35			65			95			125			155			185
5	6			36_			66			96			126			156			186
6	7			37			67			97			127			157			187
7	8			38			68			98	***************************************		128			158			188
	9			39			69			99			129			159			189
8	10			40			70			100			130			160			190
9	11			41			71			101			131			161			191
10	12			42			72			102			132			162			192
11	13			43			73			103			133			163			193
12	14	*: 1		44			74			104			134			164			194
13	15			45			75			105			135			165			195
14	16			46	5.1		76			106			136			166			196
15	17			47			77			107			137			167			197
16	18			48			78			108			138			168			198
17	19			49			79			109			139			169			199
	20			50			80			110			140			170			200
18	21			51			81			111			141			171		-	201
19	22			52			82			112			142			_172			202
20	23			53			83			113			143			173			203
21	24			54			84			114			144			174			204
22	25			55			85			115			145			175			205
23	26			56	× ×		86			116			146			176			206
24	27			57			87			117			147			177			207
	28			58			88]		118			148			178			208
	29			59			89			119	*		149			179			209
	30			60	\$		90			120	0.) 1		150			180			210